

### • General Description

The AGM420MA combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

### • Features

- Advance high cell density Trench technology
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

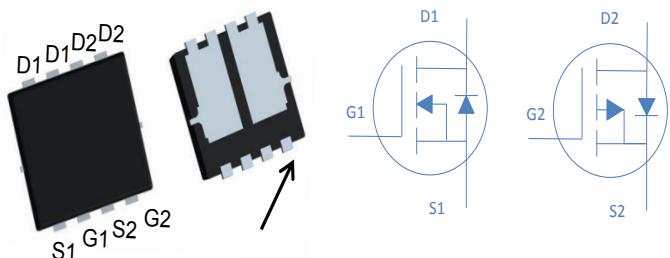
### • Application

- MB/VGA Vcore
- SMPS 2<sup>nd</sup> Synchronous Rectifier
- POL application
- BLDC Motor driver

### Product Summary

BVDSS	RDS <sub>ON</sub>	ID
40V	18mΩ	20A
-40V	26mΩ	-18A

### PDFN5\*6 Pin Configuration



### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM420MA	AGM420MA	DFN5*6	325mm	16mm	3000

Table 1. Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ )

Symbol	Parameter	Rating		Units
		N-Ch	P-Ch	
$V_{DS}$	Drain-Source Voltage ( $V_{GS}=0\text{V}$ )	40	-40	V
$V_{GS}$	Gate-Source Voltage ( $V_{DS}=0\text{V}$ )	$\pm 20$	$\pm 20$	V
$I_D$	Drain Current-Continuous( $T_c=25^\circ\text{C}$ ) <small>(Note 1)</small>	18	-20	A
	Drain Current-Continuous( $T_c=100^\circ\text{C}$ )	15	-16	A
IDM (pulse)	Drain Current-Continuous@ Current-Pulsed <small>(Note 2)</small>	50	-40	A
$P_D$	Total Power Dissipation( $T_c=25^\circ\text{C}$ )	25	31	W
	Total Power Dissipation( $T_A=100^\circ\text{C}$ )	4	5	W
EAS	Avalanche energy <small>(Note 3)</small>	31	58	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	-55 To 150	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient (Steady State) <sup>1</sup>	---	62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	5	°C/W

**Electrical Characteristics**

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics @ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	40	--	--	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current( $T_j=25^\circ\text{C}$ )	$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	$\mu\text{A}$
	Zero Gate Voltage Drain Current( $T_j=125^\circ\text{C}$ )	$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	$\pm 100$	nA
$V_{\text{GS}(\text{TH})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.2	1.7	2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance ④	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=25\text{A}$	--	18	23	$\text{m}\Omega$
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance ④	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=20\text{A}$	--	25	36	$\text{m}\Omega$
<b>Dynamic Electrical Characteristics @ <math>T_j= 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	970	1130	1230	pF
$C_{\text{oss}}$	Output Capacitance		95	100	120	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		80	90	105	pF
$R_g$	Gate Resistance	f=1MHz	--	2.2	--	$\Omega$
$Q_g$	Total Gate Charge	$V_{\text{DS}}=20\text{V}, I_{\text{D}}=20\text{A}, V_{\text{GS}}=10\text{V}$	--	20.5	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	4.9	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	4.1	--	nC
<b>Switching Characteristics</b>						
$t_{\text{d}(\text{on})}$	Turn-on Delay Time	$V_{\text{DD}}=20\text{V}, I_{\text{D}}=20\text{A}, R_{\text{G}}=3\Omega, V_{\text{GS}}=10\text{V}$				
$t_r$	Turn-on Rise Time		--	44.5	--	ns
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time		--	19	--	ns
$t_f$	Turn-Off Fall Time		--	9.2	--	ns
<b>Source- Drain Diode Characteristics@ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$V_{\text{SD}}$	Forward on voltage	$I_{\text{SD}}=25\text{A}, V_{\text{GS}}=0\text{V}$	--	0.9	1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{sd}}=20\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=100\text{A}/\mu\text{s}$	--	6.8	--	ns
$Q_{\text{rr}}$	Reverse Recovery Charge		--	1.6	--	nC

NOTE:

- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Limited by  $T_{j\text{max}}$ , starting  $T_j = 25^\circ\text{C}$ ,  $L = 0.5\text{mH}$ ,  $R_g = 25\Omega$ ,  $I_{AS} = 6\text{A}$ ,  $V_{GS} = 10\text{V}$ . Part not recommended for use above this value
- ③ The power dissipation  $P_{DSM}$  is based on  $R_{\theta,JA}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ .
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics @ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-40	--	--	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-40\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-1	$\mu\text{A}$
	Zero Gate Voltage Drain Current( $T_j=125^\circ\text{C}$ )	$V_{\text{DS}}=-40\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-100	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	$\pm 100$	nA
$V_{\text{GS}(\text{TH})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-1.0	-1.7	-2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance ②	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-15\text{A}$	--	26	34	$\text{m}\Omega$
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance ②	$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-5\text{A}$	--	34	46	$\text{m}\Omega$
<b>Dynamic Electrical Characteristics @ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	--	1112	--	pF
$C_{\text{oss}}$	Output Capacitance		--	135	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	95	--	pF
$Q_{\text{g}}$	Total Gate Charge	$V_{\text{DS}}=-20\text{V}, I_{\text{D}}=-10\text{A}, V_{\text{GS}}=-10\text{V}$	--	27	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	7.3	--	nC
$Q_{\text{qd}}$	Gate-Drain Charge		--	5.6	--	nC
<b>Switching Characteristics</b>						
$t_{\text{d}(\text{on})}$	Turn-on Delay Time	$V_{\text{DD}}=-20\text{V}, I_{\text{D}}=-10\text{A}, R_{\text{G}}=6.8\Omega, V_{\text{GS}}=-10\text{V}$	--	13	--	nS
$t_{\text{r}}$	Turn-on Rise Time		--	18	--	nS
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time		--	36	--	nS
$t_{\text{f}}$	Turn-Off Fall Time		--	25	--	nS
<b>Source- Drain Diode Characteristics@ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$V_{\text{SD}}$	Forward on voltage	$I_{\text{SD}}=-15\text{A}, V_{\text{GS}}=0\text{V}$	--	-0.89	-1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{sd}}=-10\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=-100\text{A}/\mu\text{s}$	--	34	--	nS
$Q_{\text{rr}}$	Reverse Recovery Charge			30		nC

NOTE:

① Repetitive rating; pulse width limited by max. junction temperature.

②Pulse width  $\leq 300\mu\text{s}$ ; duty cycle $\leq 2\%$ .③Limited by  $T_{\text{Jmax}}$ , starting  $T_j = 25^\circ\text{C}$ ,  $L = 0.5\text{mH}$ ,  $R_{\text{G}} = 25\Omega$ ,  $I_{\text{AS}} = -34\text{A}$ ,  $V_{\text{GS}} = -10\text{V}$ . Part not recommended for use above this value

## P-Channel Typical Characteristics

### Typical Characteristics

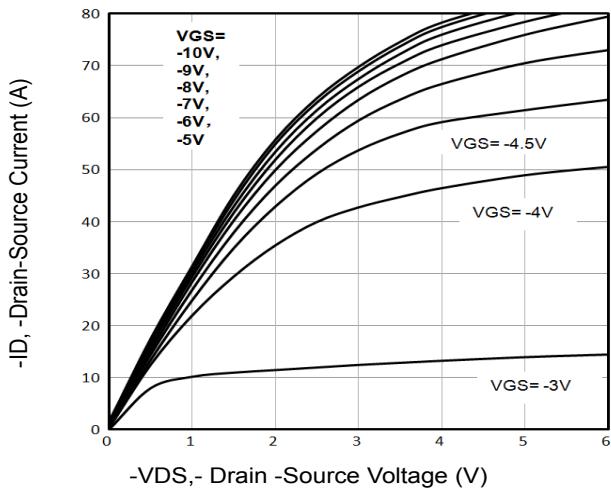


Fig1. Typical Output Characteristics

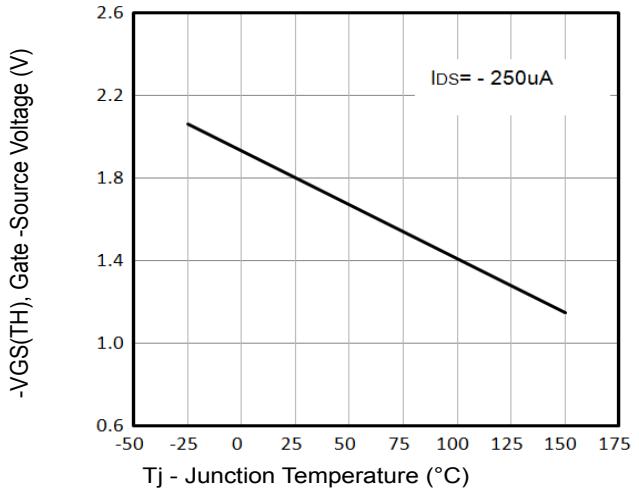


Fig2.  $-VGS(TH)$  Gate-Source Voltage Vs.  $Tj$

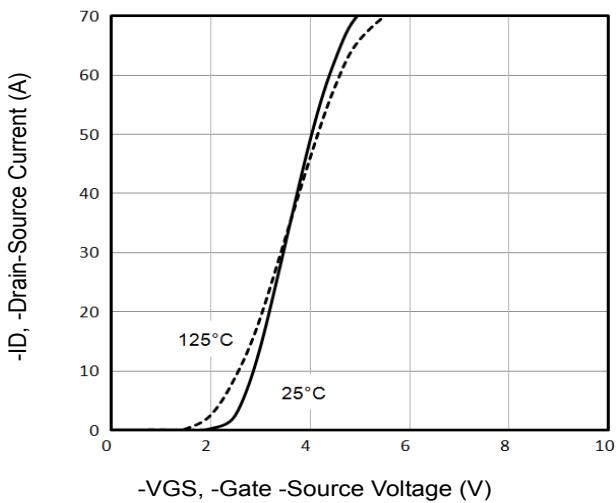


Fig3. Typical Transfer Characteristics

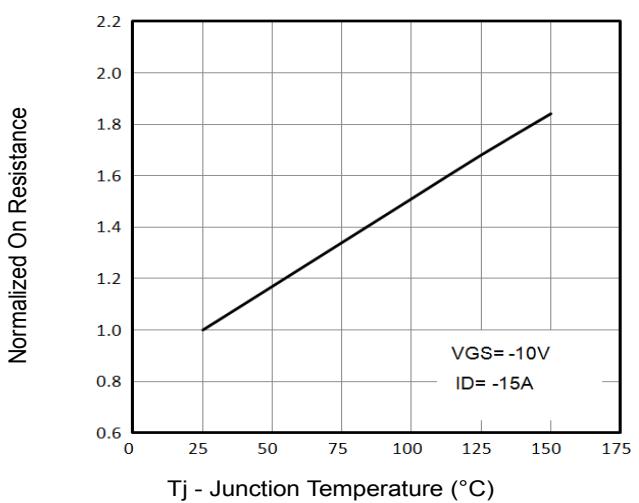


Fig4. Normalized On-Resistance Vs.  $Tj$

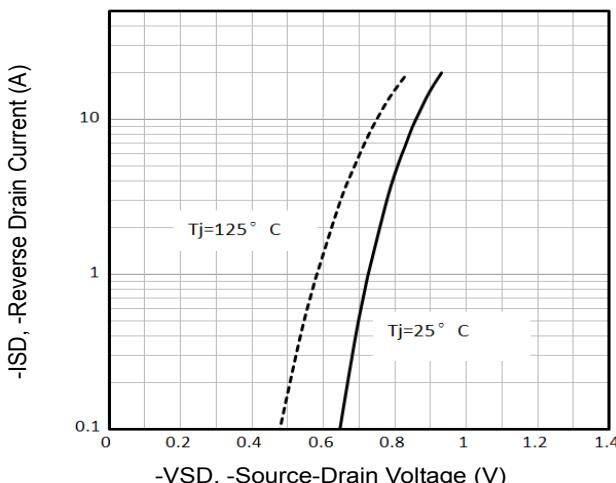


Fig5. Typical Source-Drain Diode Forward Voltage

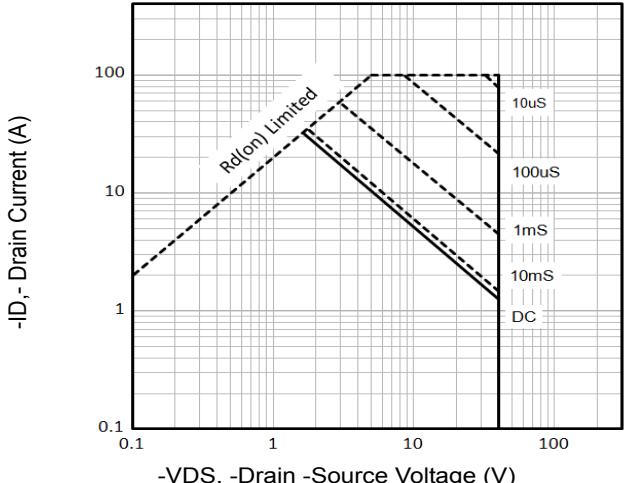


Fig6. Maximum Safe Operating Area

## Typical Characteristics

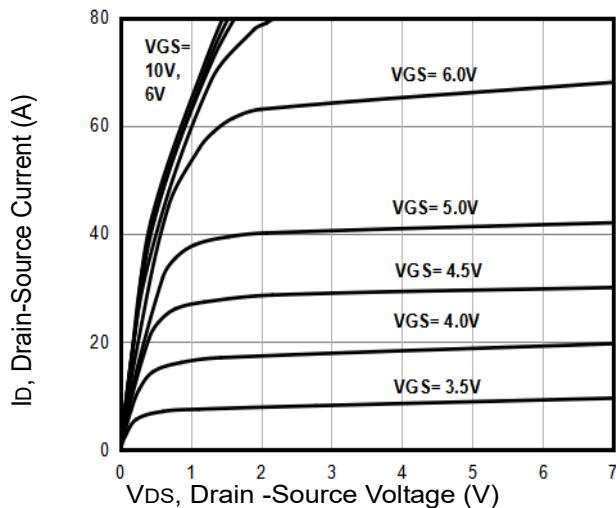


Fig1. Typical Output Characteristics

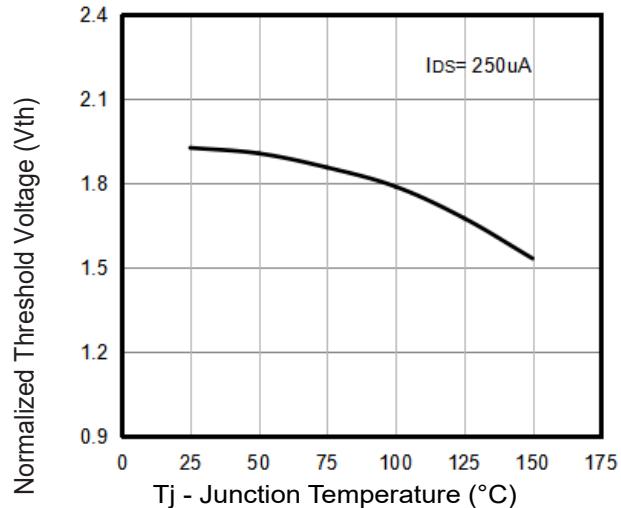


Fig2. Normalized Threshold Voltage Vs. Temperature

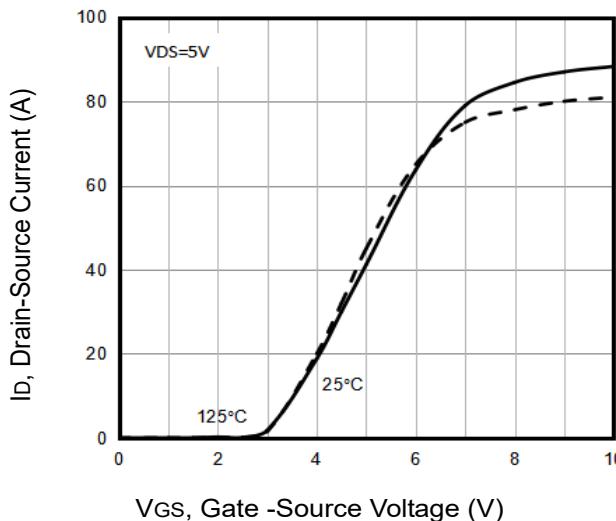


Fig3. Typical Transfer Characteristics

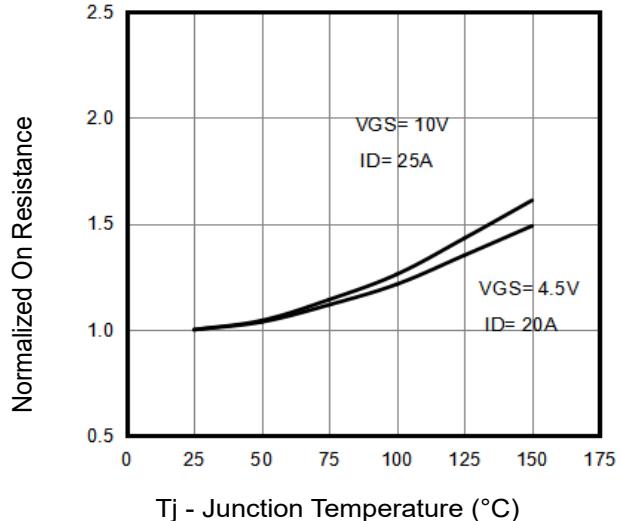


Fig4. Normalized On-Resistance Vs. Temperature

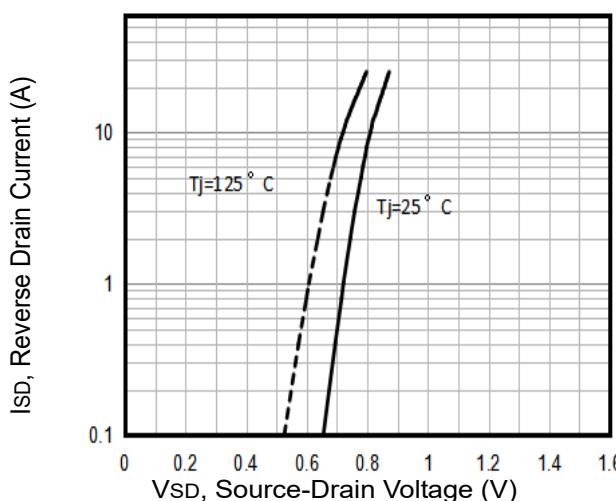


Fig5. Typical Source-Drain Diode Forward Voltage

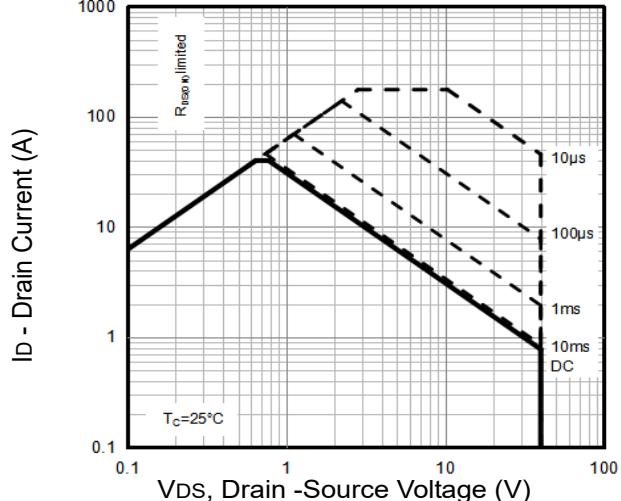
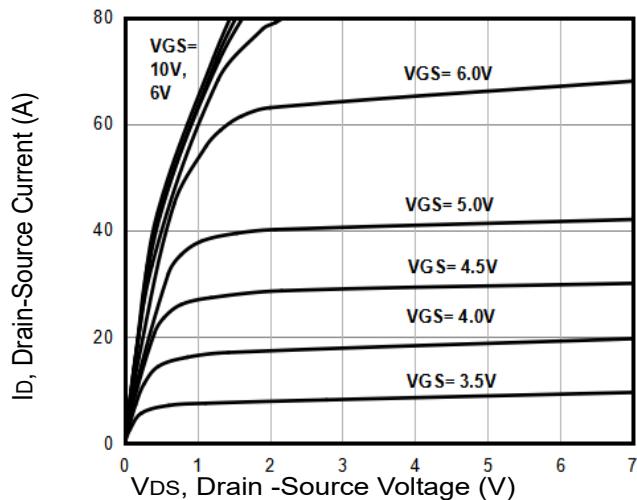
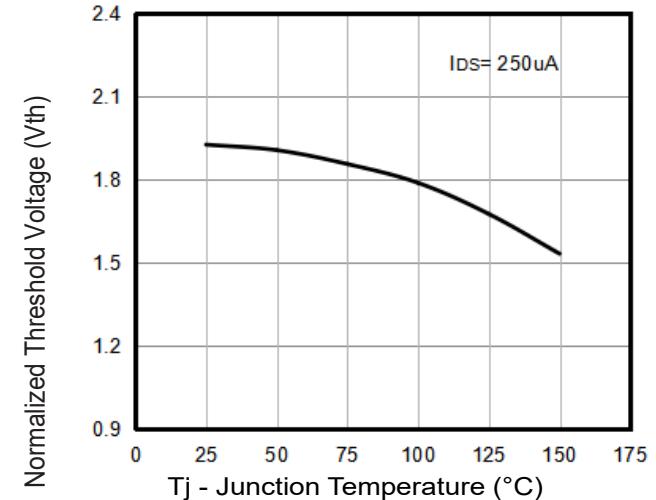
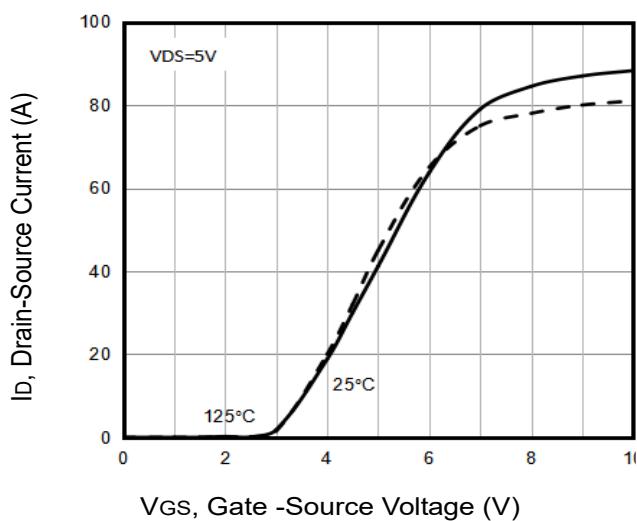
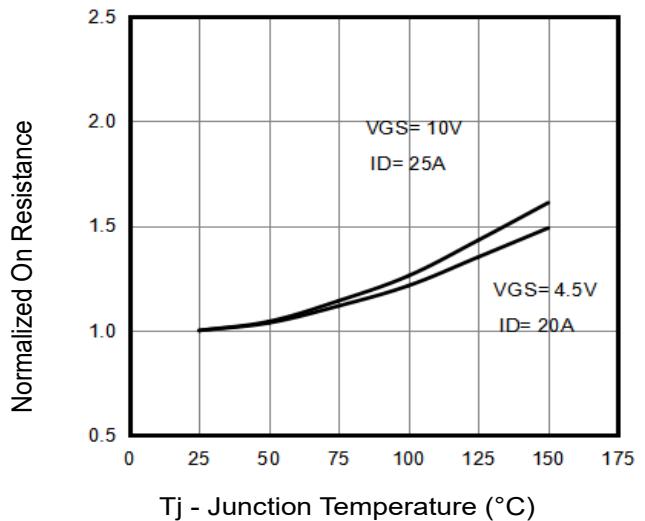
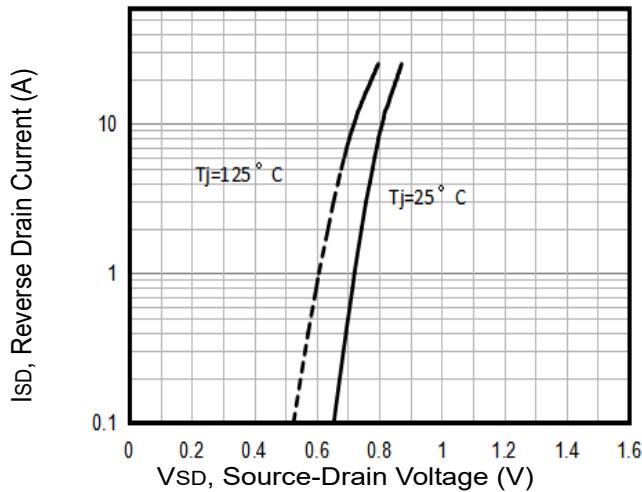
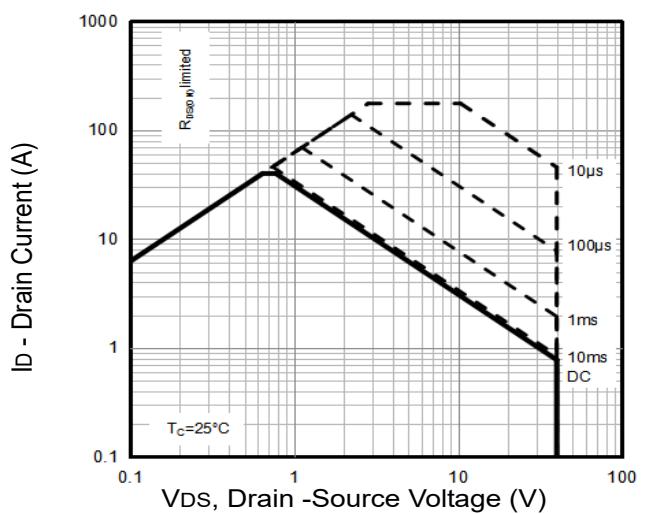


Fig6. Maximum Safe Operating Area

**N-Channel Typical Characteristics****Typical Characteristics****Fig1.** Typical Output Characteristics**Fig2.** Normalized Threshold Voltage Vs. Temperature**Fig3.** Typical Transfer Characteristics**Fig4.** Normalized On-Resistance Vs. Temperature**Fig5.** Typical Source-Drain Diode Forward Voltage**Fig6.** Maximum Safe Operating Area

## Typical Characteristics

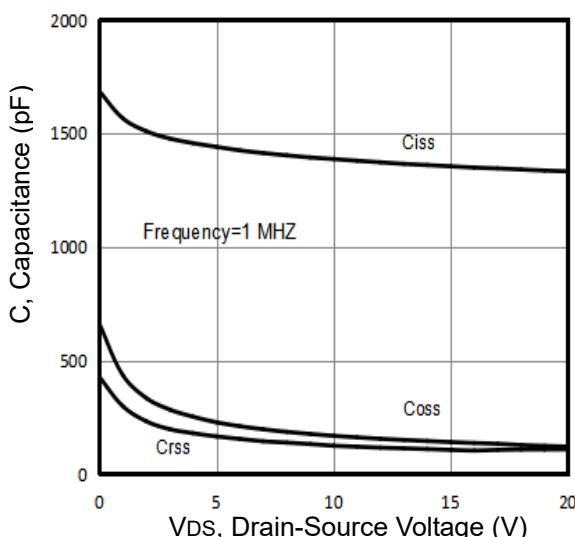


Fig7. Typical Capacitance Vs. Drain-Source Voltage

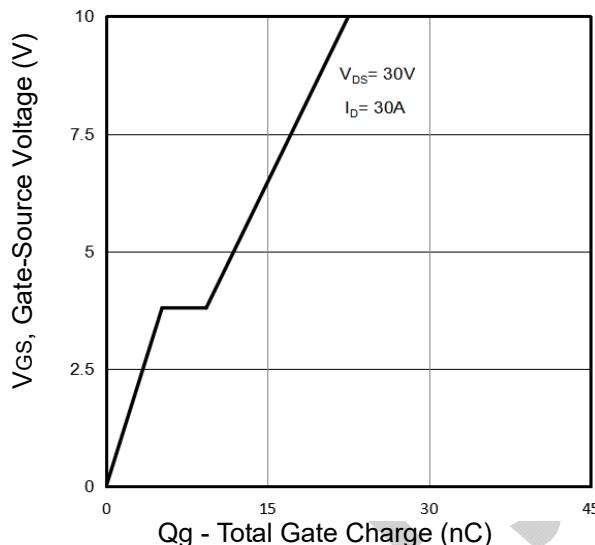


Fig8. Typical Gate Charge Vs. Gate-Source

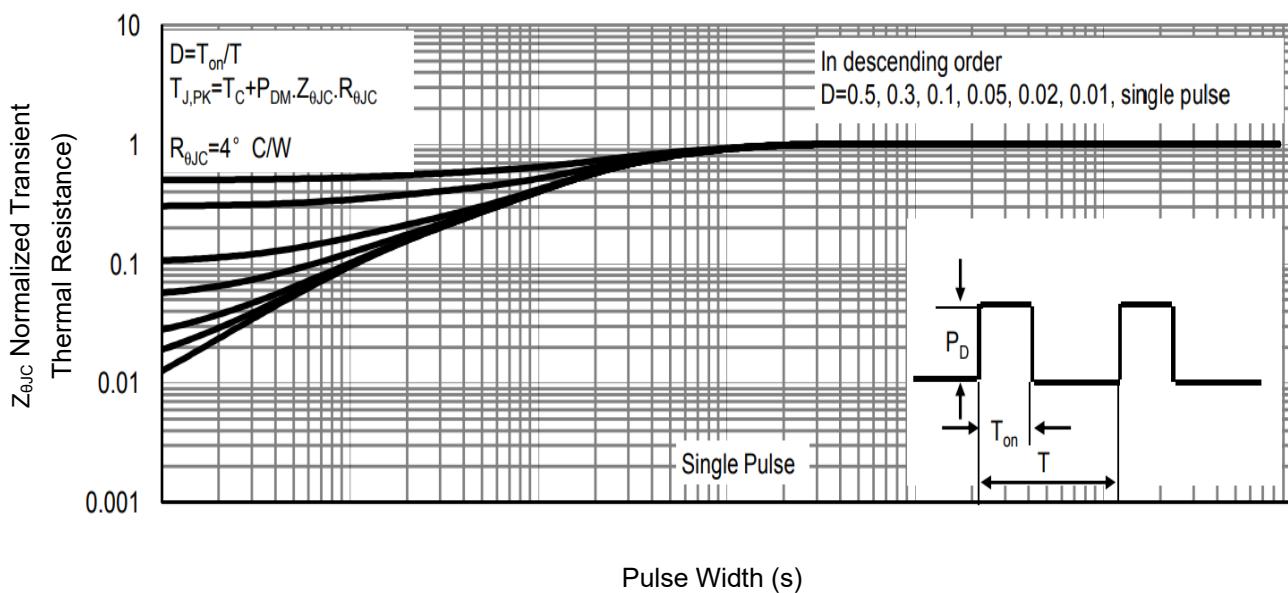


Fig9. Normalized Maximum Transient Thermal Impedance

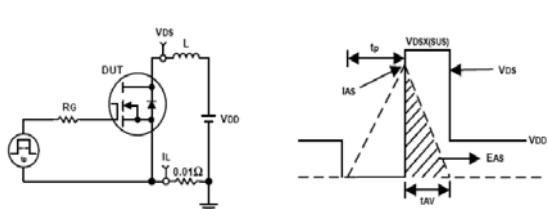


Fig10. Unclamped Inductive Test Circuit and waveforms

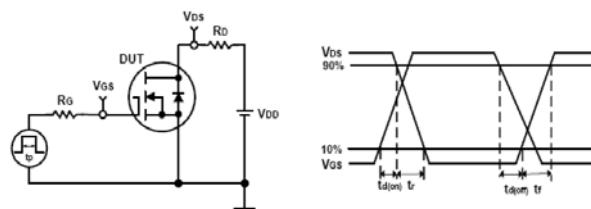
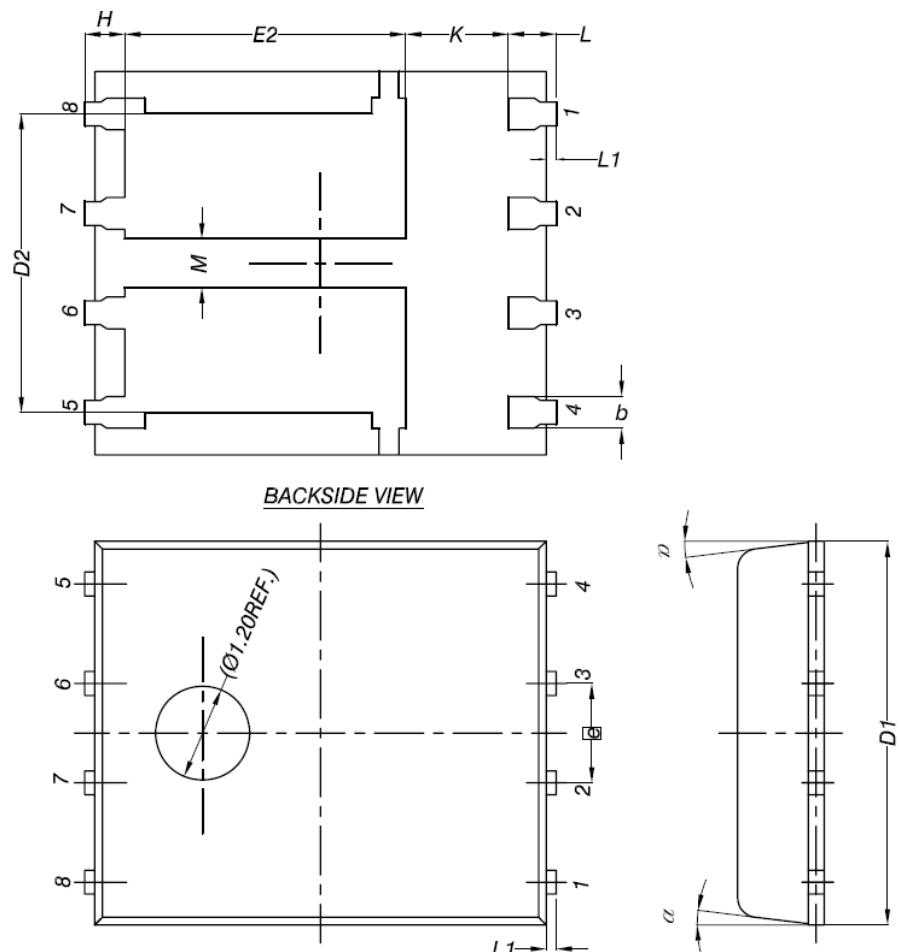


Fig11. Switching Time Test Circuit and waveforms

**PDFN5x6 Package Outline Data****DIMENSIONS ( unit : mm )**

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	0.90	1.00	1.10	e		1.27 BSC	
b	0.33	0.41	0.51	H	0.41	0.51	0.61
C	0.20	0.25	0.30	K	1.10	--	--
D1	4.80	4.90	5.00	L	0.51	0.61	0.71
D2	3.61	3.81	3.96	L1	0.06	0.13	0.20
E	5.90	6.00	6.10	M	0.50	--	--
E1	5.70	5.75	5.80	$\alpha$	0°	--	12°
E2	3.38	3.58	3.78				

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